

December 2012 SuperFET[®] II



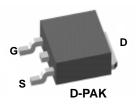
Features

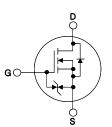
- 650V @T_J = 150°C
- Max. R_{DS(on)} = 900mΩ
- Ultra Low Gate Charge (Typ. Q_g = 13nC)
- Low Effective Output Capacitance (Typ. C_{oss}.eff = 49pF)
- 100% Avalanche Tested
- ESD Improved Capacity

Description

SuperFET[®]II is, Fairchild's proprietary, new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET[®]II is very suitable for various AC/DC power conversion in switching mode operation for system miniaturization and higher efficiency.





Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		FCD900N60Z	Units			
V _{DSS}	Drain to Source Voltage		600	V		
V _{GSS}		-DC		±20	V	
	Gate to Source Voltage	-AC	(f>1Hz)	±30	V	
ID	Drain Current	-Continuous ($T_C = 25^{\circ}C$)		4.5	- A	
		-Continuous (T _C = 100 ^o C)		3.5		
I _{DM}	Drain Current	- Pulsed	13.5	А		
E _{AS}	Single Pulsed Avalanche Energy (Note			47.5	mJ	
I _{AR}	Avalanche Current		(Note 1)	1	A	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	0.52	mJ		
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	20	V/ns		
	MOSFET dv/dt			100	V/ns	
P _D	Bower Dissinction	$(T_{C} = 25^{\circ}C)$		52	W	
	Power Dissipation	- Derate above 25°C		0.42	W/ºC	
T _J , T _{STG}	Operating and Storage Temp	-55 to +150	°C			
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	FCD900N60Z	Units	
R_{\thetaJC}	Thermal Resistance, Junction to Case	2.4	°C/W	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	100	°C/W	

Device Marking		Device	Packag		Reel Size		e Width		Quantit	y
FCD900	FCD900N60Z FCD900N60Z D-F		D-PAK		380mm	1	6mm		2500	
Electrica	I Char	acteristics T _c =	25°C unless	otherwise	noted					
Symbol		Parameter			Test Condition	s	Min.	Тур.	Max.	Units
Off Chara	cteristic	S								
				$V_{cc} = 0$	V, I _D = 10mA, T _J :	= 25°C	600	-	-	V
3V _{DSS}	Drain to Source Breakdown Voltage		oltage				650	-	-	V
ABV _{DSS}	Breakdo	own Voltage Temperat	ure	$V_{GS} = 0V, I_D = 10mA, T_J = 150^{\circ}C$						-
ΔT_{J}		Coefficient		$I_D = 10$ mA, Referenced to 25°C			-	0.72	-	V/ºC
BV _{DS}		ource Avalanche Brea	ikdown	$V_{GS} = 0V, I_D = 4.5A$			_	700	-	V
	Voltage	Voltage		00 0						•
DSS			ent		$80V, V_{GS} = 0V$		-	-	5	μA
				$V_{DS} = 480V, T_{C} = 125^{\circ}C$			-	-	20	
GSSF		ody Leakage Current,			$0V, V_{DS} = 0V$		-	-	10	uA
GSSR	Gate-Body Leakage Current, Reverse			$V_{GS} = -2$	$20V, V_{\text{DS}} = 0V$		-	-	-10	uA
On Charac	teristics	6								
/ _{GS(th)}	Gate Th	reshold Voltage		$V_{CS} = V$	′ _{DS} , I _D = 250μA		2.5	-	3.5	V
RDS(on)		rain to Source On Res	sistance		$0V, I_D = 2.3A$			0.82	0.90	Ω
JFS		Transconductance			0V, I _D = 2.3A	(Note 4)	-	4.6	-	S
				00	· D	, ,		-		
Oynamic (Characte	eristics		I		1			1	
C _{iss}		apacitance		– V _{DS} = 25V, V _{GS} = 0V			-	543	720	pF
Soss	Output (Capacitance		$v_{DS} = 25^{\circ}, v_{GS} = 0^{\circ}$ f = 1MHz		-	-	400	530	pF
Srss	Reverse	e Transfer Capacitance	e				-	20	30	pF
Soss	Output 0	Capacitance		$V_{DS} = 380V, V_{GS} = 0V, f = 1.0MHz$ $V_{DS} = 0V \text{ to } 480V, V_{GS} = 0V$ $V_{DS} = 380V, I_D = 2.3A$			-	11	-	pF
C _{oss} eff.	Effective	e Output Capacitance					-	49	-	pF
⊋ _{g(tot)}	Total Ga	te Charge at 10V					-	13	17	nC
ג _{gs}		Source Gate Charge		$V_{GS} = T$	V _{GS} = 10V		-	2.3	-	nC
ጋ _{gd}	Gate to	Drain "Miller" Charge		(Note 4)			-	4.8	-	nC
ESR	Equivale	uivalent Series Resistance		Drain open			-	2.4	-	Ω
Switching	Charact	aristics								
	1	Delay Time					-	10.0	32	
d(on)		,		$V_{DD} = 380V, I_D = 2.3A$ $V_{GS} = 10V, R_G = 4.7\Omega$		-	10.9	-	ns	
r		Rise Time				-	5.3	21	ns	
d(off)		Delay Time					-	33.6	77	ns
f	Tum-Oil	Fall Time				(Note 4)	-	11.9	34	ns
)rain-Sou	rce Dioc	le Characteristic	S							
S	Maximur	m Continuous Drain to	Source Diode	e Forward	l Current		-	-	4.5	Α
SM	Maximur	m Pulsed Drain to Sou	Irce Diode For	rward Cur	rent		-	-	13.5	Α
/ _{SD}	Drain to	Source Diode Forwar	d Voltage	$V_{GS} = 0V, I_{SD} = 2.3A$		-	-	1.2	V	
rr		Recovery Time		$V_{GS} = 0V, I_{SD} = 2.3A$		-	156	-	ns	
ک _{rr}	Reverse	Recovery Charge		$dI_F/dt = 100A/\mu s$			-	1.3	-	μC
otes:										
Repetitive Ratir	g: Pulse width	limited by maximum junctior	temperature							

8

1.6

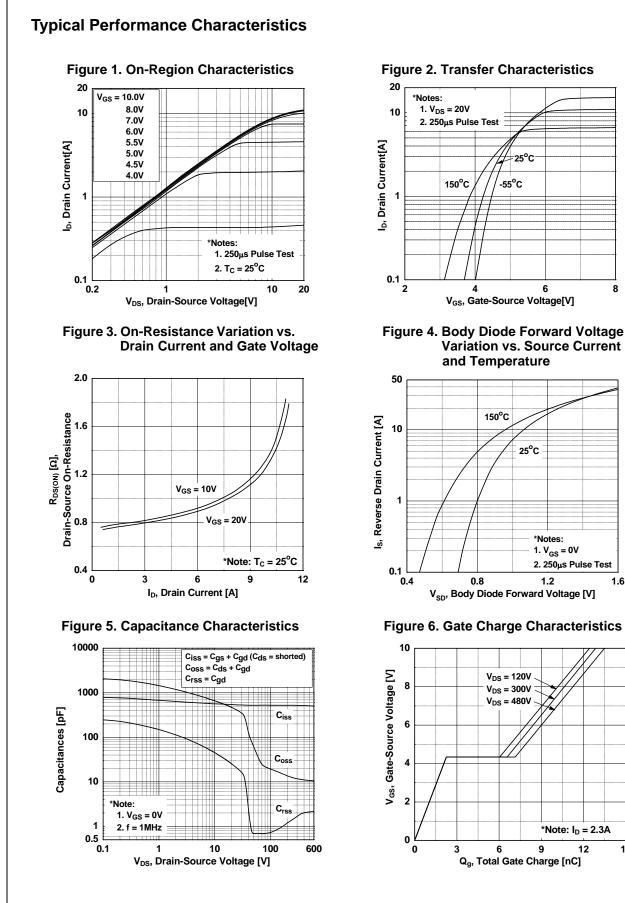


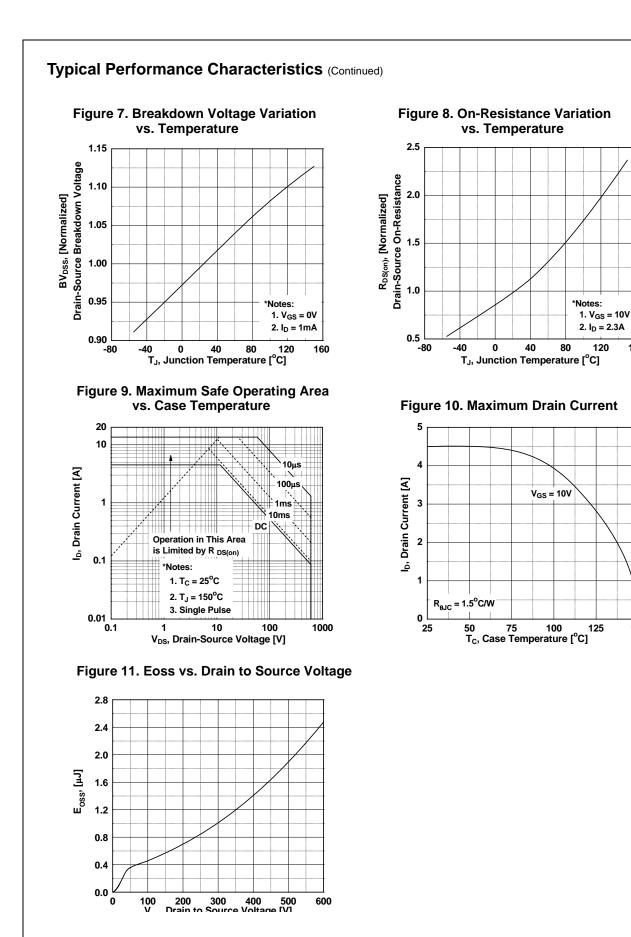
Figure 2. Transfer Characteristics

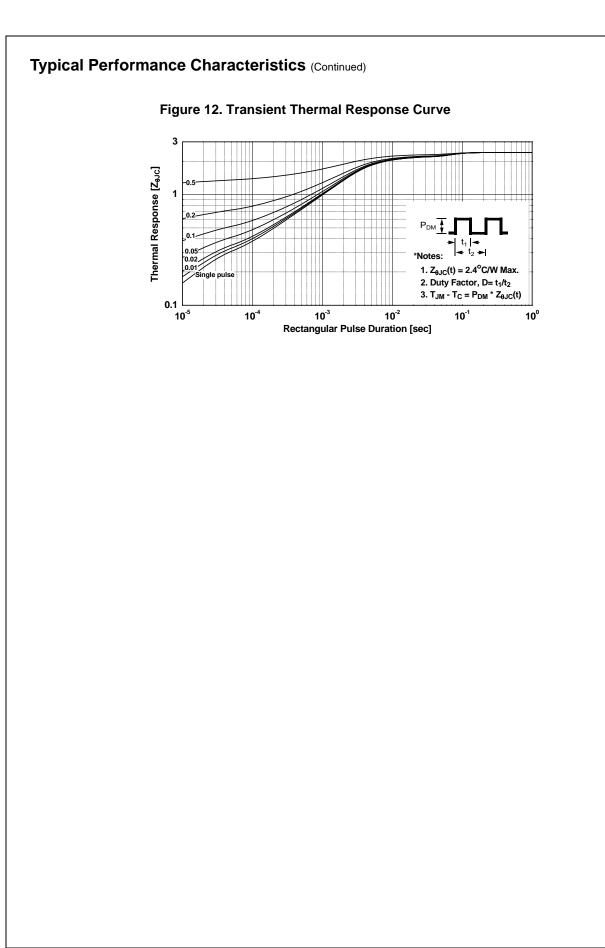
15

12

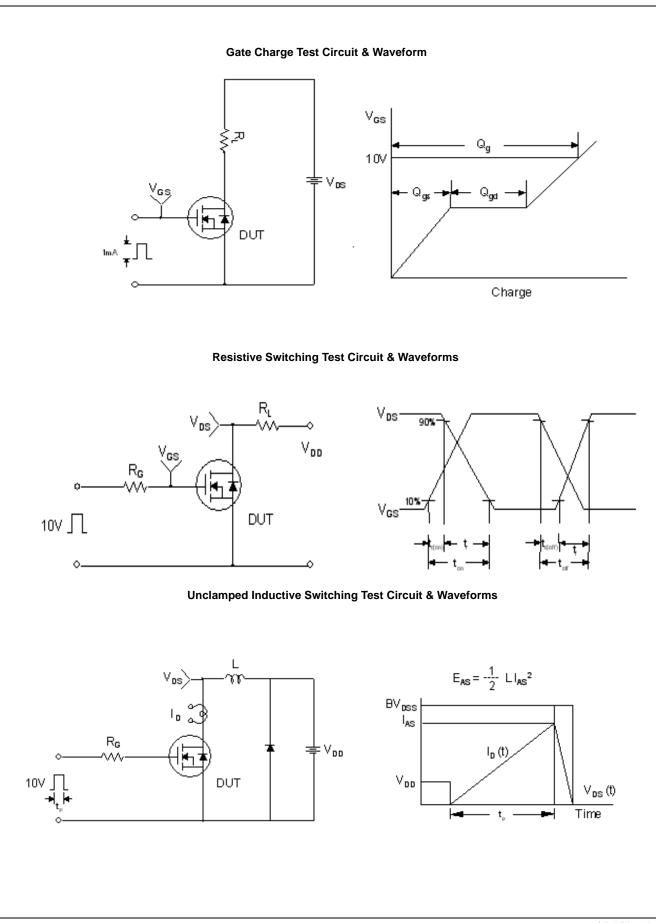
160

150



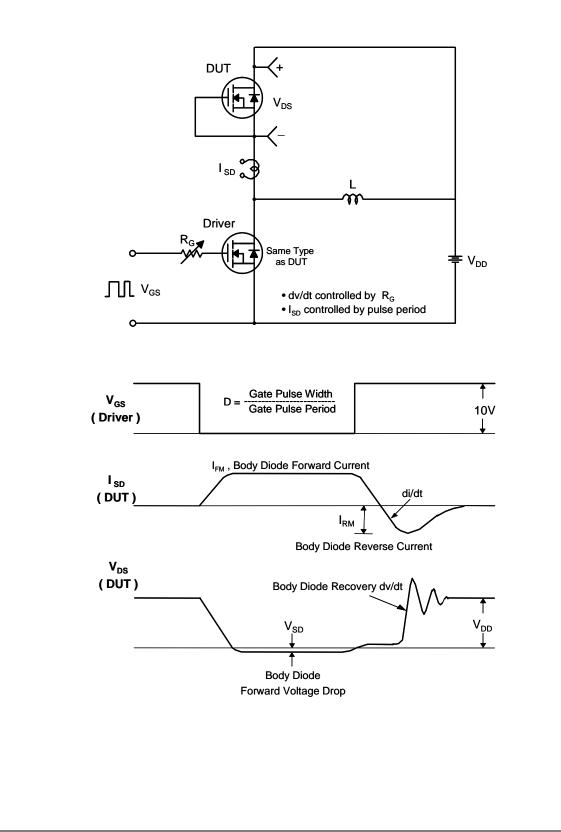


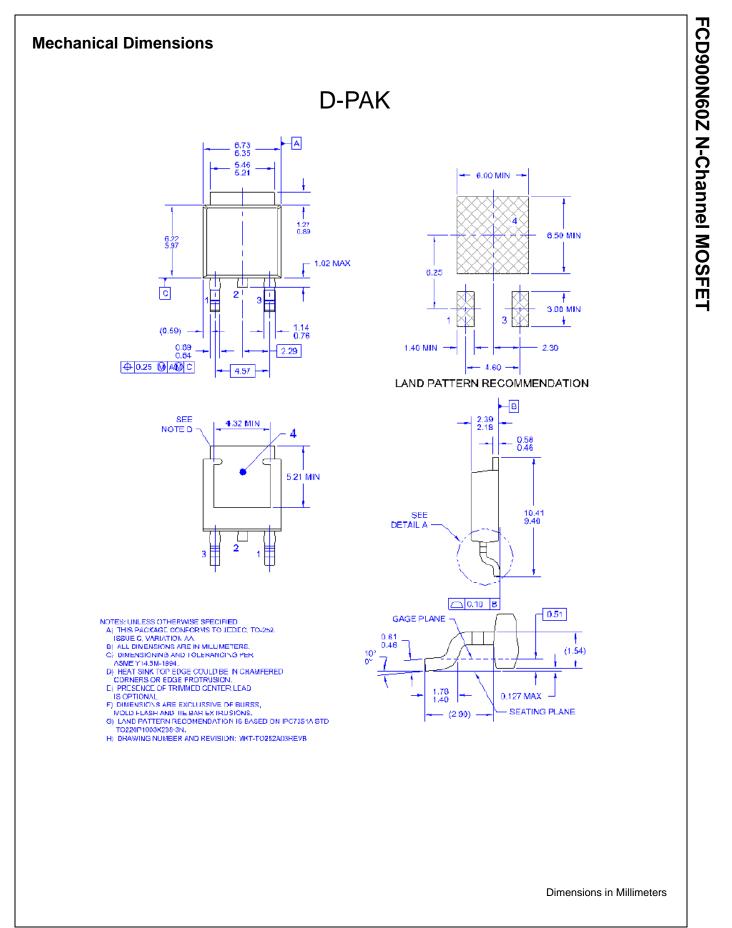
FCD900N60Z N-Channel MOSFET



FCD900N60Z N-Channel MOSFET









SEMICONDUCTOR

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

2Cool™ AccuPower™ AX-CAP™* BitSiC[®] Build it Now™ CorePLUS™ CorePOWER™ CROSSVOLT™ CTL™ Current Transfer Logic™ DEUXPEED® Dual Cool™ EcoSPARK[®] EfficentMax™ ESBC™

Fairchild® Fairchild Semiconductor® FACT Quiet Series™ FACT® FAST® FastvCore™ FETBench™ FlashWriter[®] * FPS™

FRFET® Global Power ResourceSM Green Bridge™ Green FPS[™] Green FPS™ e-Series™ Gmax™ GTO™ IntelliMAX™ **ISOPLANAR™** Marking Small Speakers Sound Louder and Better[™] MegaBuck™ MICROCOUPLER™ MicroFET™ MicroPak™ MicroPak2™ MillerDrive™ MotionMax™ Motion-SPM™ mWSaver™ OptoHiT™ **OPTOLOGIC[®] OPTOPLANAR[®]** R

F-PFS™

PowerTrench[®] PowerXS™ Programmable Active Droop™ OFFT[®] QS™ Quiet Series™ RapidConfigure™ тм Saving our world, 1mW/W/kW at a time™ SignalWise™ SmartMax™ SMART START™ Solutions for Your Success™ SPM[®] STEAL TH™ SuperFET[®] SuperSOT™-3

SuperSOT™-6

SuperSOT[™]-8

SupreMOS®

SyncFET™

Sync-Lock™

GENERAL

SYSTEM ®

The Power Franchise[®] bwer p franchise TinyBoost™ TinyBuck™ TinyCalc™ TinyLogic[®] TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™ TranSiC[®] TriFault Detect™ TRUECURRENT®* uSerDes™ N UHC® Ultra FRFET™

UniFET™ VCX™ VisualMax™ VoltagePlus™ XS™

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are 1. intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a la date. Fairchild Semiconductor reserves the right to make changes at any time with notice to improve design.			
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.			

Rev. 161